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## SN65LBC174A-EP

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# SN65LBC174A-EP Quadruple RS-485 Differential Line Driver

## 1 Features

• VID V62/07611

**EXAS** 

Instruments

- Designed for TIA/EIA-485, TIA/EIA-422, and ISO 8482 applications
- Signaling rates up to 30 Mbps (1)
- Propagation delay times < 11 ns
- Low standby power consumption 1.5-mA max
- · Driver positive- and negative-current limiting
- Power-up and power-down glitch free for lineinsertion applications
- Thermal shutdown protection
- Industry standard pinout, compatible with SN75174, MC3487, DS96174, LTC487, and MAX3042
- Supports defense, aerospace, and medical applications
  - Controlled baseline
  - One assembly and test site
  - One fabrication site
  - Available in military (–55°C to 125°C) temperature range
  - Extended product life cycle
  - Extended product-change notification
  - Product traceability
- The signaling rate of a line is the number of voltage transitions that are made per second, expressed in the unit bits per second (bps).

## 2 Applications

- Transmission at signaling rates up to 30 Mbps
- Avionics, radar
- GPS navigation for missiles
- Industrial transportation
- High-speed multipoint data transmission applications in noisy environments

## **3** Description

The SN65LBC174A-EP is a quadruple differential line driver with tri-state outputs, designed for TIA/EIA-485 (RS-485), TIA/EIA-422 (RS-422), and ISO 8482 applications.

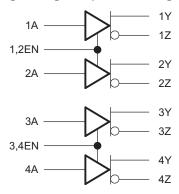
This device is optimized for balanced multipoint bus transmission at signaling rates up to 30-million bits per second (Mbps). The transmission media may be printed-circuit-board traces, backplanes, or cables. The ultimate rate and distance of data transfer is dependent upon the attenuation characteristics of the media and the noise coupling to the environment.

### **Device Information**<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
SN65LBC174A-EP	SOIC (20)	7.50 × 12.80
SINOOLDC174A-EP	SOIC (16)	7.50 × 10.30

(1) For all available packages, see the orderable addendum at the end of the data sheet.

## Logic Diagram (Positive Logic)





# **Table of Contents**

1	Feat	ures 1						
2	Applications 1							
3	Description 1							
4	Revision History							
5	Description (continued) 3							
6	Pin	Configuration and Functions 4						
7	Spe	cifications						
	7.1	Absolute Maximum Ratings 5						
	7.2	ESD Ratings 5						
	7.3	Recommended Operating Conditions5						
	7.4	Thermal Information 5						
	7.5	Electrical Characteristics						
	7.6	Switching Characteristics						
	7.7	Typical Characteristics						
8	Para	ameter Measurement Information						
9	Deta	ailed Description 14						
	9.1	Overview 14						

	9.2	Functional Block Diagram	14
	9.3	Feature Description	14
	9.4	Device Functional Modes	14
10	Арр	lication and Implementation	15
	10.1	Application Information	15
	10.2	Typical Application	15
11	Pow	ver Supply Recommendations	17
12	Lay	out	18
	12.1	Layout Guidelines	18
	12.2	Layout Example	18
13	Dev	ice and Documentation Support	19
	13.1	Receiving Notification of Documentation Updates	19
	13.2		
	13.3	Trademarks	19
	13.4	Electrostatic Discharge Caution	
	13.5		19
14		hanical, Packaging, and Orderable	
	Info	rmation	20

## **4** Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

C	nanges from Original (December 2006) to Revision A	Page
•	Updated data sheet to superior standards	1
•	Added pinout drawing for 16-pin DW	3
•	Added 16-pin DW and updated the Pin Functions table	4
•	Added ESD value for 16-pin DW package	5
•	Added updated thermal metrics	5

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## **5** Description (continued)

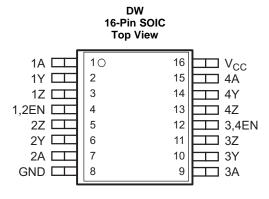
Each driver features current limiting and thermal-shutdown circuitry, making it suitable for high-speed multipoint applications in noisy environments. The device is designed using LinBiCMOS<sup>™</sup> technology, facilitating low power consumption and robustness.

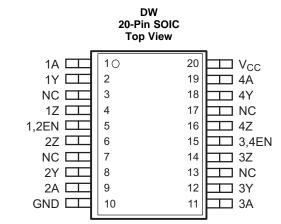
The two enable (EN) inputs provide pair-wise driver enabling, or can be externally tied together to provide enable control of all four drivers with one signal. When disabled or powered off, the driver outputs present a high impedance to the bus for reduced system loading.

The SN65LBC174A-EP is characterized for operation over the temperature range of -55°C to 125°C.

4

# 6 Pin Configuration and Functions





#### Pin Functions

PIN		1/0	DESCRIPTION		
NAME	16 PINS	20 PINS	- I/O	DESCRIPTION	
1A	1	1	Digital input	Port 1 A data input	
1Y	2	2	Bus output	Bus port 1 Y (complementary to 1 Z)	
NC	_	3	No Connect	Physically not connected in package	
1Z	3	4	Bus output	Bus port 1 Z (complementary to 1 Y)	
1,2EN	4	5	Digital input	Bus output port 1 and 2 driver enable	
2Z	5	6	Bus output	Bus port 2 Z (complementary to 2 Y)	
NC	—	7	No Connect	Physically not connected in package	
2Y	6	8	Bus output	Bus port 2 Y (complementary to 2 Z)	
2A	7	9	Digital input	Port 2 A data input	
GND	8	10	Ground	Device ground	
ЗA	9	11	Digital input	Port 3 A data input	
3Y	10	12	Bus output	Bus port 3 Y (complementary to 3 Z)	
NC	—	13	No Connect	Physically not connected in package	
3Z	11	14	Bus output	Bus port 3 Z (complementary to 3 Y)	
3,4EN	12	15	Digital input	Bus output port 3 and 4 driver enable	
4Z	13	16	Bus output	Bus port 4 Z (complementary to 4 Y)	
NC	—	17	No Connect	Physically not connected in package	
4Y	14	18	Bus output	Bus port 4 Y (complementary to 4 Z)	
4A	15	19	Digital input	Port 4 A data input	
V <sub>CC</sub>	16	20	V <sub>CC</sub>	Device power	



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## 7 Specifications

## 7.1 Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
$V_{CC}$	Supply voltage <sup>(2)</sup>	-0.3	6	V
	Voltage at any bus (dc)	-10	15	V
	Voltage at any bus (transient pulse through 100 $\Omega$ , See Figure 14)	-30	30	V
VI	Input voltage at any A or EN terminal	-0.5	$V_{CC} + 0.5$	V
T <sub>stg</sub>	Storage temperature <sup>(3)</sup>	-65	150	°C
	Lead temperature 1.6 mm (1/16 in) from case for 10 s		260	°C

Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
 All voltage values, except differential I/O bus voltages, are with respect to GND.

(3) Long-term high-temperature storage and/or extended use at maximum recommended operating conditions may result in a reduction of overall device life.

## 7.2 ESD Ratings

				VALUE	UNIT	
	, Electrostatic		Y, Z (20-pin DW)	±13,000		
V			Y, Z (16-pin DW)	±10,000		
V <sub>(ESD)</sub>	discharge		All other pins	±5000	v	
		Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	All pins	±1000		

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

## 7.3 Recommended Operating Conditions

			MIN	NOM	MAX	UNIT
$V_{CC}$	Supply voltage		4.75	5	5.25	V
	Voltage at any bus terminal	Y, Z	-7		12	V
VIH	High-level input voltage	A, EN	2		$V_{CC}$	V
VIL	Low-level input voltage	A, EN	0		0.8	V
	Output current		-60		60	mA
T <sub>A</sub>	Operating free-air temperature		-55		125	°C

## 7.4 Thermal Information

		SN65LB0	C174A-EP		
	THERMAL METRIC <sup>(1)</sup>	DW (	DW (SOIC)		
		20 PINS	16 PINS		
$R_{\thetaJA}$	Junction-to-ambient thermal resistance	61.3	60.4	°C/W	
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	26.2	24.3	°C/W	
$R_{\thetaJB}$	Junction-to-board thermal resistance	29.3	26.1	°C/W	
ΨJT	Junction-to-top characterization parameter	4.9	4.1	°C/W	
Ψјв	Junction-to-board characterization parameter	28.8	25.6	°C/W	
R <sub>0JC(bot)</sub>	Junction-to-case (bottom) thermal resistance	n/a	n/a	°C/W	

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC package thermal metrics application report.

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## 7.5 Electrical Characteristics

### over recommended operating conditions

	PARAMETER	TEST CON	DITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
V <sub>IK</sub>	Input clamp voltage	I <sub>I</sub> = -18 mA		-1.5	-0.77		V
Vo	Open-circuit output voltage	Y or Z, No load	Y or Z, No load			$V_{CC}$	V
		No load (open circuit)		3		V <sub>CC</sub>	
V <sub>OD(SS)</sub>	Steady-state differential output voltage magnitude <sup>(2)</sup>	$R_L = 54 \Omega$ , See Figure 7	7	0.8	1.6	2.5	V
	Voltage magnitude of	With common-mode loa	ding, See Figure 8	0.8	1.6	2.5	
$\Delta V_{OD(SS)}$	Change in steady-state differential output voltage between logic states	See Figure 7	See Figure 7			0.1	V
V <sub>OC(SS)</sub>	Steady-state common-mode output voltage	See Figure 9		2	2.4	2.8	V
$\Delta V_{OC(SS)}$	Change in steady-state common-mode output voltage between logic states	See Figure 9		-0.04		0.04	V
I <sub>I</sub>	Input current	A, G, <del>G</del>		-70		70	μΑ
			$V_{I} = 0 V$	000		000	
los	Short-circuit output current	$V_{\text{TEST}} = -7 \text{ V}$ to 12 V,	$V_I = V_{CC}$	-200		200	mA
I <sub>OZ</sub>	High-impedance-state output current	See Figure 13	EN at 0 V	-50		50	μΑ
I <sub>O(OFF)</sub>	Output current with power off		$V_{CC} = 0 V$	-10		10	μA
	Quark summer	$V_{I} = 0 V \text{ or } V_{CC},$	All drivers enabled				
I <sub>CC</sub>	Supply current	No load	All drivers disabled				mA

All typical values are at V<sub>CC</sub> = 5 V and 25°C.
 The minimum V<sub>OD</sub> may not fully comply with TIA/EIA-485-A at operating temperatures below 0°C. System designers should take the possibility of lower output signal into account in determining the maximum signal transmission distance.



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## 7.6 Switching Characteristics

over recommended operating conditions

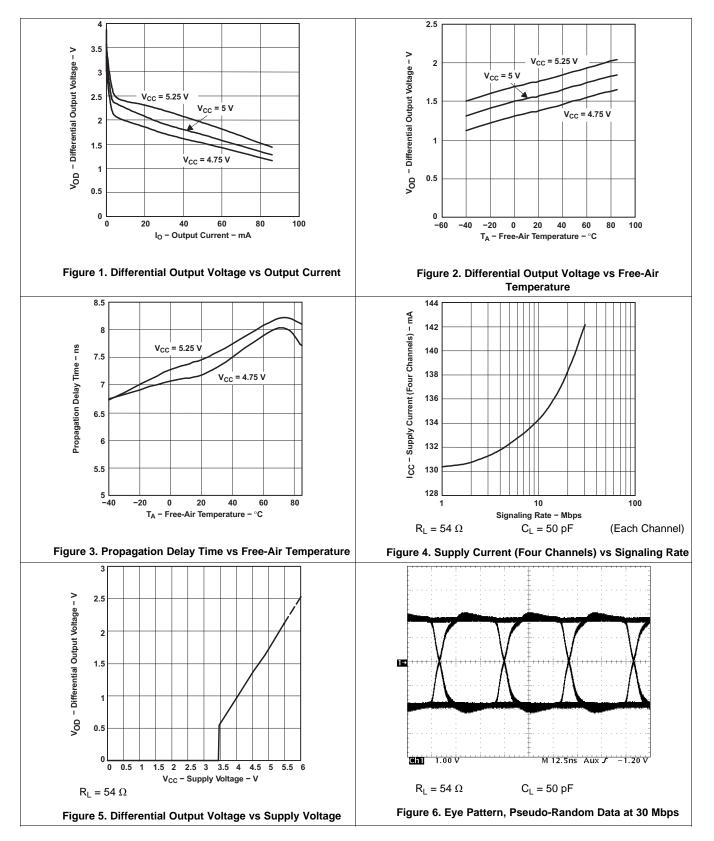
	PARAMETER	TEST CO	NDITIONS	MIN	TYP	MAX	UNIT
	Propagation dolou time, low, to high lovel output		T <sub>A</sub> = 25°C	4.0	8	11	
t <sub>PLH</sub>	Propagation delay time, low- to high-level output		$T_A$ = -55°C to 125°C	4.0		16	ns
+	Propagation dolay time, high to law lovel output		T <sub>A</sub> = 25°C	4.0	8	11	ns
t <sub>PHL</sub>	Propagation delay time, high- to low-level output		$T_A$ = -55°C to 125°C	4.0		16	ns
+	Differential output voltage rise time		T <sub>A</sub> = 25°C	3	7.5	11	20
t <sub>r</sub>	Differential output voltage rise time $R_L = 54 \Omega, C_L = 50 pF,$ Differential output voltage fall timeSee Figure 10		$T_A$ = -55°C to 125°C	3		24	ns
+		T <sub>A</sub> = 25°C	3	7.5	11	20	
t <sub>f</sub>	Differential output voltage fall time		$T_A$ = -55°C to 125°C	3		24	ns
t <sub>sk(p)</sub>	Pulse skew  t <sub>PLH</sub> - t <sub>PHL</sub>				0.6		ns
t <sub>sk(o)</sub>	Output skew <sup>(1)</sup>				2		ns
t <sub>sk(pp)</sub>	Part-to-part skew <sup>(2)</sup>				3		ns
t <sub>PZH</sub>	Propagation delay time, high impedance to high- level output	See Figure 11				25	ns
t <sub>PHZ</sub>	Propagation delay time, high-level output to high impedance	See Figure 11				25	ns
t <sub>PZL</sub>	Propagation delay time, high impedance to low- level output	See Figure 10				30	ns
t <sub>PLZ</sub>	Propagation delay time, low-level output to high impedance	See Figure 12				20	ns

(1) Output skew (t<sub>sk(o)</sub>) is the magnitude of the time delay difference between the outputs of a single device with all of the inputs connected together.

(2) Part-to-part skew (t<sub>sk(pp)</sub>) is the magnitude of the difference in propagation delay times between any specified terminals of two devices when both devices operate with the same input signals, the same supply voltages, at the same temperature, and have identical packages and test circuits.



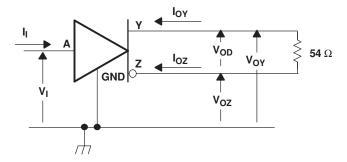
## 7.7 Typical Characteristics

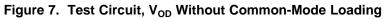




#### SLLS732A-OCTOBER 2006-REVISED NOVEMBER 2019

## 8 Parameter Measurement Information





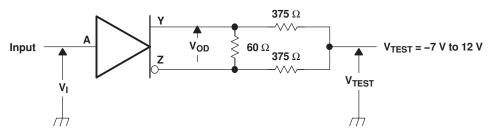
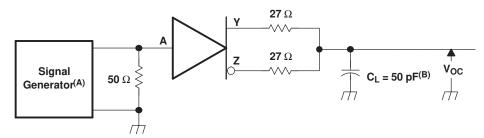


Figure 8. Test Circuit, V<sub>OD</sub> With Common-Mode Loading

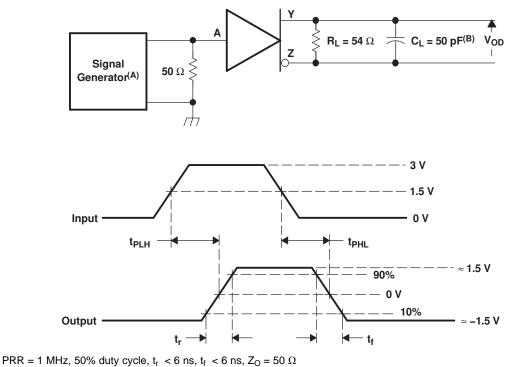


PRR = 1 MHz, 50% duty cycle,  $t_r\,$  < 6 ns,  $t_f\,$  < 6 ns,  $Z_O$  = 50  $\Omega$  Includes probe and jig capacitance.

## Figure 9. V<sub>OC</sub> Test Circuit



## Parameter Measurement Information (continued)

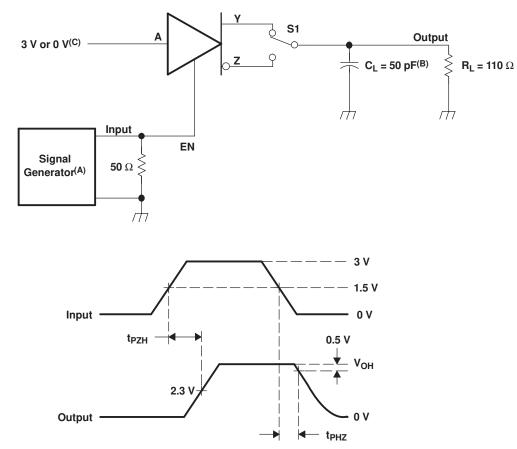


Includes probe and jig capacitance.

### Figure 10. Output Switching Test Circuit and Waveforms







### **Parameter Measurement Information (continued)**

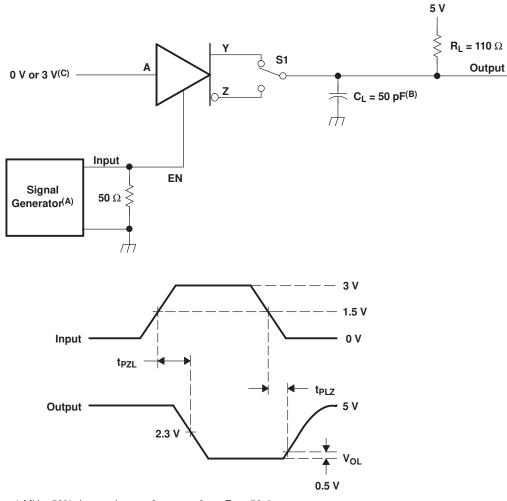
PRR = 1 MHz, 50% duty cycle,  $t_r\,$  < 6 ns,  $t_f\,$  < 6 ns,  $Z_O$  = 50  $\Omega$  Includes probe and jig capacitance.

3 V if testing Y output, 0 V if testing Z output.

## Figure 11. Enable Timing Test Circuit and Waveforms, $T_{\text{PZH}}$ and $T_{\text{PHZ}}$

TEXAS INSTRUMENTS

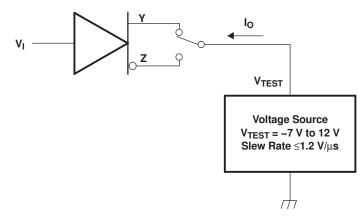
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## **Parameter Measurement Information (continued)**

 $\label{eq:PRR} \begin{array}{l} \mbox{= 1 MHz, 50\% duty cycle, } t_r \ < 6 \ \mbox{ns, } t_f \ < 6 \ \mbox{ns, } Z_O = 50 \ \Omega \end{array}$  Includes probe and jig capacitance. 3 V if testing Y output, 0 V if testing Z output.





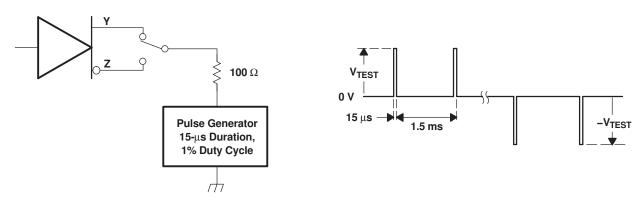




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Parameter Measurement Information (continued)





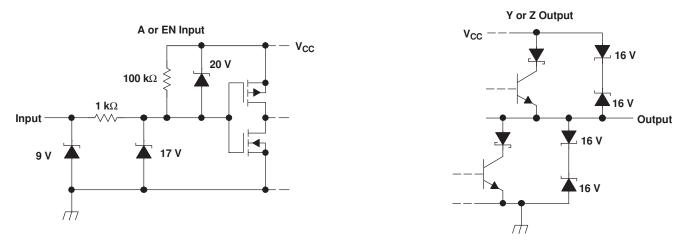


Figure 15. Equivalent Input and Output Schematic Diagrams

TEXAS INSTRUMENTS

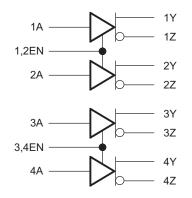
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## 9 Detailed Description

### 9.1 Overview

The SN65LBC174A-EP is a quadruple differential line driver with tri-state outputs, designed for TIA/EIA-485 (RS-485), TIA/EIA-422 (RS-422), and ISO 8482 (Euro RS-485) applications. This device is optimized for balanced multipoint bus communication at data rates up to and exceeding 30 million bits per second. The transmission media may be twisted-pair cables, printed-circuit board traces, or backplanes. The ultimate rate and distance of data transfer is dependent upon the attenuation characteristics of the media and the noise coupling to the environment. The transmitter features ESD protection to 12 kV on driver outputs, making it suitable for high-speed multipoint data transmission applications in harsh environments. These devices are designed using LinBiCMOS, facilitating low-power consumption and robustness. Two EN inputs provide pair-wise enable control, or these can be tied together externally to enable all four drivers with the same signal.

## 9.2 Functional Block Diagram



## 9.3 Feature Description

The device can be configured using the enable inputs to enable driver pairs 1 and 2, and/or 3 and 4. The high voltage or logic 1 on the EN pin enables the devices differential outputs.

## 9.4 Device Functional Modes

The drivers implemented in the RS-485 device can be configured using the EN logic pins set to enabled or disabled. This allows users to transmit or idle the bus as desired.

INPUT	ENABLE	OUTPUTS					
Α	G	Y	Z				
L	Н	L	Н				
н	Н	н	L				
OPEN	Н	н	L				
L	OPEN	L	н				
н	OPEN	н	L				
OPEN	OPEN	н	L				
Х	L	Z	Z				

### Table 1. Function Table<sup>(1)</sup> (Each Driver)

(1) H = high level, L = low level, X = irrelevant,

Z = high impedance (off)



#### SLLS732A-OCTOBER 2006-REVISED NOVEMBER 2019

## **10** Application and Implementation

### NOTE

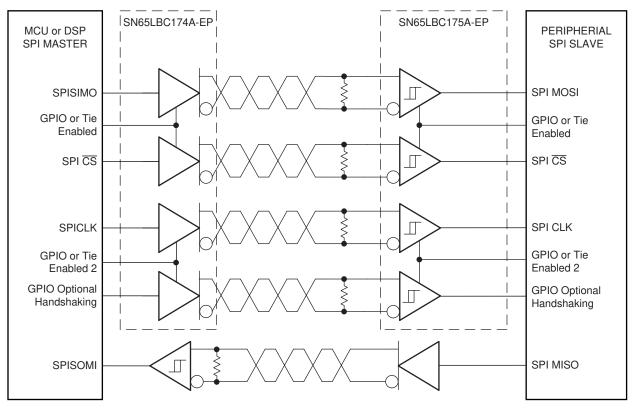
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

## **10.1** Application Information

Extending SPI operation over RS-485 link.

## **10.2 Typical Application**

The following block diagram shows an MCU host connected via RS-485 to a SPI slave device. This device can be an ADC, DAC, MCU, or other SPI slave peripheral.



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## Figure 16. Typical Application Circuit, MCU Master to Slave Link Via Serial Peripheral Interface

## 10.2.1 Design Requirements

This application can be implemented using standard SPI protocol on DSP or MCU devices. The interface is independent of the specific frame or data requirements of the host or slave device. An additional but not required handshake bit is provided that can be used for customer purposes.

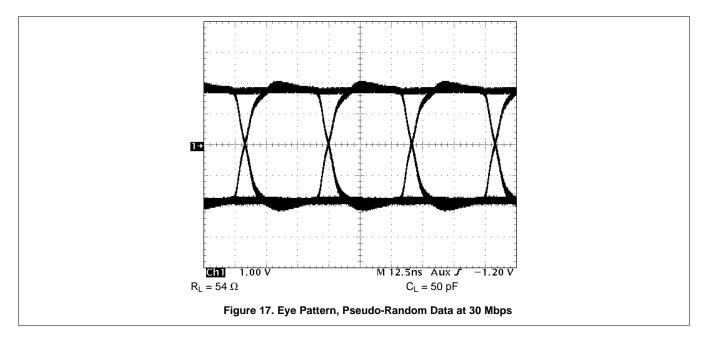


### **Typical Application (continued)**

### 10.2.2 Detailed Design Procedure

The interface design requirements are fairly straight forward in this single source/destination scenario. Trace lengths and cable lengths need to be matched to maximize SPI timing. If there is a benefit to put the interface to sleep, GPIOs can be used to control the enable signals of the transmitter and receiver. If GPIOs are not available, or constant uptime needed, both the enables on transmit and receive can be hard tied enabled. The link shown can operate at up to 30 Mbps, well within the capability of most SPI links.

### 10.2.3 Application Curve





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## **11** Power Supply Recommendations

Place  $0.1-\mu F$  bypass capacitors close to the power-supply pins to reduce errors coupling in from noisy or high-impedance power supplies.



## 12 Layout

## 12.1 Layout Guidelines

For best operational performance of the device, use good PCB layout practices including:

- Noise can propagate into analog circuitry through the power pins of the circuit as a whole, as well as the
  operational amplifier. Bypass capacitors are used to reduce the coupled noise by providing low-impedance
  power sources local to the analog circuitry.
- Connect low-ESR, 0.1-μF ceramic bypass capacitors between each supply pin and ground, placed as close to the device as possible.
- Place termination resistor as close as possible to the input pins (if end point node).
- Keep trace lengths from input pins to bus as short as possible to reduce stub lengths and reflections on any nodes that are not end points of bus.
- To reduce parasitic coupling, run the input traces as far away from the supply or output traces as possible. If it is not possible to keep them separate, it is much better to cross the sensitive trace perpendicular as opposed to in parallel with the noisy trace.

## 12.2 Layout Example

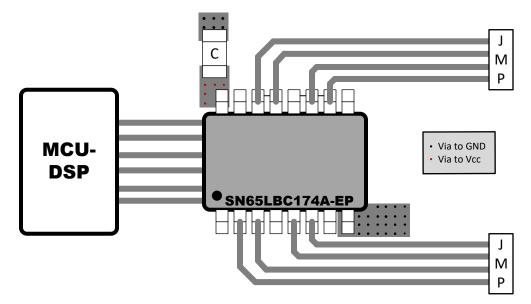


Figure 18. Layout With PCB Recommendations



## **13** Device and Documentation Support

### 13.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 13.2 Support Resources

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

### 13.3 Trademarks

LinBiCMOS, E2E are trademarks of Texas Instruments. All other trademarks are the property of their respective owners.

#### 13.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

## 13.5 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

SLLS732A-OCTOBER 2006-REVISED NOVEMBER 2019



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## 14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



10-Dec-2020

## PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
65LBC174AM16DWREP	ACTIVE	SOIC	DW	16	2000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-55 to 125	65LBC174EP	Samples
SN65LBC174AMDWREP	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	65LBC174EP	Samples
V62/07611-01XE	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	65LBC174EP	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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# PACKAGE OPTION ADDENDUM

10-Dec-2020

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF SN65LBC174A-EP :

• Catalog: SN65LBC174A

NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product

# PACKAGE MATERIALS INFORMATION

www.ti.com

Texas Instruments

## TAPE AND REEL INFORMATION





# QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
65LBC174AM16DWREP	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
SN65LBC174AMDWREP	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1

TEXAS INSTRUMENTS

www.ti.com

# PACKAGE MATERIALS INFORMATION

19-Jan-2020



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
65LBC174AM16DWREP	SOIC	DW	16	2000	350.0	350.0	43.0
SN65LBC174AMDWREP	SOIC	DW	20	2000	350.0	350.0	43.0

# **DW 16**

# **GENERIC PACKAGE VIEW**

## SOIC - 2.65 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT

7.5 x 10.3, 1.27 mm pitch

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





# **DW0016A**



# **PACKAGE OUTLINE**

SOIC - 2.65 mm max height

SOIC



#### NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  This drawing is subject to change without notice.
  This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.
- 5. Reference JEDEC registration MS-013.



# DW0016A

# **EXAMPLE BOARD LAYOUT**

## SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



# DW0016A

# **EXAMPLE STENCIL DESIGN**

# SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.



# **DW0020A**



# **PACKAGE OUTLINE**

## SOIC - 2.65 mm max height

SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



# DW0020A

# **EXAMPLE BOARD LAYOUT**

# SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



# DW0020A

# **EXAMPLE STENCIL DESIGN**

# SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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